

Embedding Defect and Traceability Information in CIM- and PIM-Level Software Models

Jörg Rech and Mario Schmitt

Fraunhofer IESE, Fraunhofer-Platz 1, 67663 Kaiserslautern, Germany
+49 (0) 631 6800 2210, Joerg.Rech@iese.fraunhofer.de
+49 (0) 631 6800 2215, Mario.Schmitt@iese.fraunhofer.de

Abstract. Additional information about software models comes in different forms such as defects detected, design patterns used, traceability information to other abstraction levels, etc. In this paper, we present how additional information about defects, context, traceability, etc. can be embedded into UML- and BPMN-based PIM- and CIM-level software models. Furthermore, we present a tool that uses the information about quality defects within a PIM to visualize defects directly in the diagrams of a software model.

Keywords: Quality Defects, PIM, CIM, Traceability, Defect Annotation, Traceability Annotation, Embedded Information, Software Models, MDSD

1 Introduction

Business users together with business analysts and architects generate the basic characteristics of a software system that result in computation independent models (CIM), including, e.g., role, product, or process models. In order to support the traceability of elements and of decisions made on the CIM-level to the PIM-level as well as the traceability of problems identified at the PIM-level to the CIM-level, we have to store additional information about the software model along with the software model.

Additional information about elements in a software model such as a PIM or CIM comes in different forms such as quality defects detected, patterns (roles) used, traceability information to other abstraction levels, etc. This information is documented by users or automated mechanisms and has to be visualized in standard or special views of a modeling tool, made available to other systems for further analysis (e.g. impact analyses), or persisted over a long period of time.

Kolovos et al. [7] differentiate between external and embedded traceability information and decided on using an external approach. They argue against the embedded approach (based on stereotypes), as it does not support inter-model relations, pollutes the models, and degrades uniformity.

However, while several other options are possible beside stereotypes, storing additional complex information in a metamodel such as the UML [11] for PIM level is not straightforward. An extension of the UML metamodel would result in non-standard models that are not exchangeable between tools. Besides, in order to apply similar mechanisms to models at different abstraction levels based on different (or previously

unknown) metamodels, we need a generic approach that can be easily adapted to and complies with a broad range of metamodels.

In our context, the de-facto metamodel on the PIM level is UML [11], which is built using the OMG's Meta Object Facility (MOF) meta-metamodel. MOF is a common modeling language kernel providing a unified basis for all OMG metamodels. On the CIM level, modeling focuses on business process modeling using mostly the Business Process Modeling Notation BPMN [2] and the Business Process Definition Metamodel BPDM [1]. While BPMN provides just a graphical notation for process orchestration, BPDM is a CIM-level metamodel for business process modeling, using BPMN as the graphical notation. Similar to UML, BPDM is based on the MOF [8] meta-metamodel.

Several solutions to the abovementioned problem of embedding information into software models are possible. In order to store the information in an Eclipse-based IME for PIMs, such as Topcased [10], and for CIMs, such as the BPMN-Editor of the SOA Tools Platform (STP) [4], we can persist information as:

- *Markers/Properties* in/of the software model that are managed and stored by the tool, but cannot easily be shared between users or across a versioning system (e.g., CVS)
- *MOF Tag*, a construct in MOF that enables the multiple "tagging" of MOF model elements with attribute-value pairs and can be shared across a versioning system,
- *Comment*, a construct of MOF and many other metamodels (e.g., "Text Annotations" in BPMN) similar to MOF Tag for storing a single additional information item (i.e., text field) per element, but, typically, is used for developer documentation,
- *UML Profile/Stereotype*, an extension mechanism in UML that can be used to integrate additional elements into the UML. However, the information might be confused with, domain-specific stereotypes for example and could flood the user with too much information, not necessary in day-to-day work,
- *External files*, similar to diagram interchange [3] files in Topcased, which use a semantic bridge to refer to elements of the software model(s). However, these files need to be used by the tools at work in order to synchronize changes to the model elements.

In order to enable the annotation of elements in a MOF-based software model, with respect to providing easily synchronizable and versionable information, we selected MOF Tags to persist information about defects detected, context factors, and traceability information. Furthermore, the tagging mechanism allows embedding complex information within a software model using an XML schema to describe and structure the specific content for every specific annotation. The XML schema represents a metamodel that allows us to define the substructures for the information on defects, traceability, etc.

2 A Metamodel for Defect and Traceability Annotations

While traceability and context information has to be annotated manually (for now), defects are identified by diagnostic mechanisms that analyze the system and find

typical recurring problems, that have a negative effect on internal quality aspects (e.g., maintainability, portability, or usability).

The five types of defect-related embedded information are: *Defect Annotations* (with information about the diagnosed quality defects), *Context Annotations* (with context information on design patterns and roles applied or on special stereotypes, used to differentiate the diagnosis), *Decision Annotations* (with decisions such as “ignore” for individually diagnosed quality defects in case they are wrongly diagnosed or not removable in this specific location), *Symptom Annotations* (with information on the identified symptoms), and *Treatment Annotations* (which are used to store the treatments applicable for removing the diagnosed quality defects).

Traceability information uses just one type of annotation (*Trace Annotations*) that realizes traces from one element to one or more other elements (e.g., from one CIM element to multiple PIM elements (downwards), from one PIM to multiple CIM elements (upwards), or from one PIM to multiple other PIM elements (sideways)). Multiple types of references can be used *between abstractions* and *within abstractions*.

Furthermore, while single-location defects are enclosed within one abstraction at one element, *multi-location defects* refer to other elements (resp. annotations) within the same model, and all defects might refer to elements on another abstraction level to document rationales for not removing a defect or to pinpoint a cause or (design) decision (e.g., in a CIM).

Figure 1 shows different aspects. On the OMG-specification-side (right), it outlines the generic approach as proposed by MOF for annotating model elements with additional information (metainformation) using the *Tag* entity. It introduces the base model elements of BPMN-based CIMs (*BPDM::Element*) and UML-based PIMs (*UML::Element*) both deriving from *MOF::Element*, which acts as common model element abstraction. Eclipse provides for these concepts either an OMG-conformant implementation or analog concepts that can be easily mapped (center of Figure 1) to OMG. For MOF, the element *MOF::Element* is mapped to the *Ecore* element *Ecore::EModelElement* of the Eclipse Modeling Framework (EMF) and *MOF::Tag* is mapped to *Ecore::EAnnotation*. Similarly, for CIM-modeling, the BPMN element *BPDM::Element* is mapped to the SOA Tools Platform (STP) project object *STP::BPMN::NamedBpmnObjects*. Finally, the element *UML::Element* of OMG’s UML is implemented (as a one-to-one representation) by the Model Development Tools (MDT) project’s *UML2 MDT::UML2::Element*.

Furthermore, Figure 1 presents an XML-based metamodel (left) for defect- and traceability-oriented model metainformation and shows how actual metainformation is embedded using the tagging mechanism/within annotations. A metamodel similar to the traceability information metamodel is used by Feng et al. [6] for external traceability models.

A model element may have multiple annotations (*EAnnotations*) associated with it, each consisting of a *source* URI denoting an annotation’s type and an arbitrary number of *key/value* pairs. Following the structure of annotations, we bundle all model metainformation in a single annotation element, but internally distribute information to multiple *key/value* pairs according to the information’s scope/type (e.g. «Traceability» or «Quality»). That is, *key* determines the type/scope of the XML-based metainformation assigned to *value*.

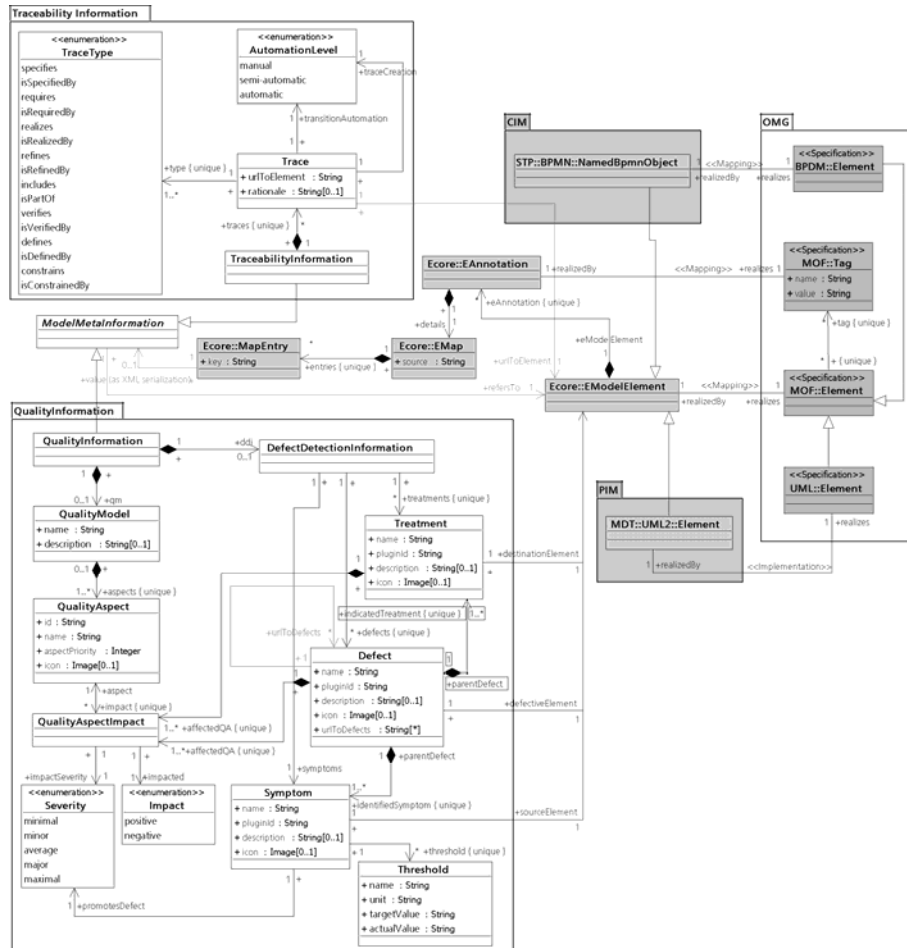


Figure 1 Metamodel for Quality and Traceability Information in CIM and PIM Models

Figure 2 gives a simplified, exemplary XMI serialization of a UML-based PIM model with a model element annotated with *quality information*. Quality information consists of *quality model* and *defect detection information*. According to the (non-functional) requirements a software system has to meet, a quality model defines and prioritizes mandatory *quality aspects* and thus, is the basis for interpreting/verifying the quality of a software model. In the context of VIDE-DD, determining the quality of a software model focuses on detecting *quality defects*. A quality defect represents a system-independent defect at one or more model elements with a negative *impact* on certain *quality aspects*. Defects are diagnosed on the basis of one or more quantifiable characteristics of a model or its model elements, so-called *symptoms*. The intensity with which symptoms promote related defects differs and amongst other things, largely depends on the characteristic's deviation from previously defined *threshold(s)*. For removing a defect or mitigating a defect's (negative) impact on certain quality aspects, *treatments* refer to available techniques (e.g. refactorings). The exemplary annotation in Figure 2 illustrates the concept of *defect detection information*: A *Lazy*

Class defect has been diagnosed for the PIM-level class *Opportunity* based on the *Number of Operations*. Hence, a negative impact on the declared quality aspect *Maintainability* is expected, treatable by applying an *Inline Class* refactoring.

```

<uml:Model>
...
<packagedElement xmi:type="uml:Class" xmi:id="_CyIsaF-fEdySHqLLXw_Tew"
name="Opportunity">
<eAnnotations source="http://www.iese.fraunhofer.de/ModelMetaInformation">
<details key="QualityInformation" value="
<!-- BEGIN: Embedded QualityInformation XML-string -->
<QualityInformation>
<DefectDetectionInformation>
<Defects>
<Defect name="Lazy Class" description="Class Opportunity provides
not enough functionality to justify its existence."
pluginId="diagnosis.lazyclass"
defectiveElement="_CyIsaF-fEdySHqLLXw_Tew">
<IdentifiedSymptoms>
<Symptom name="Number of Operations"
description="Number of operations is below threshold"
pluginId="analysis.noo"
sourceElement="_CyIsaF-fEdySHqLLXw_Tew"
parentDefect="diagnosis.lazyclass" promotesDefect="major">
<Thresholds>
<Threshold name="Lower Threshold"
unit="Integer" targetValue="6" actualValue="2"/>
</Thresholds>
</Symptom>
</IdentifiedSymptoms>
<AffectedQualityAspects>
<QualityAspectImpact id="ISO9126_Maintainability"
impact="negative" severity="major"/>
</AffectedQualityAspects>
<IndicatedTreatments>
<Treatment name="Inline Class"
description="Move all features of Opportunity into another class and delete it."
pluginId="refactoring.inlineclass"
destinationElement="_CyIsaF-fEdySHqLLXw_Tew"
parentDefect="diagnosis.lazyclass"/>
</IndicatedTreatments>
</Defect>
</Defects>
</DefectDetectionInformation>
<QualityModel name="" description="">
<QualityAspect id="ISO9126_Maintainability"
name="Maintainability"
description="The ease with which a software system or component can be modified..."
aspectPriority="2"/>
</QualityModel>
</QualityInformation>
<!-- END: Embedded QualityInformation XML-string -->
"/>
</eAnnotations>
</packagedElement>
...
</uml:Model>

```

Figure 2 Serialization of Quality Information Annotation

Furthermore, we distinguish single- from multi-location defects [9]. A single-location defect (e.g. Lazy Class) affects one model element (e.g., a class), whereas

multi-location defects apply to more than one element within the same model. For example, a *Shotgun Surgery* defect is present when, due to strong coupling of classes, a change in one class requires many subsequent changes in other classes. As each concerned class is annotated with defect information, it is necessary to interrelate this information, e.g. in order to elicit and apply adequate treatments. Thus, *urlToDefects* (cf. Figure 1) allows for referencing related defects in other model elements.

A model element's *traceability information* comprises one to many *traces* to elements, both at different and at same abstraction levels. As presented in Figure 3, the key component of a trace is *urlToElement* for identifying related elements using a URL reference. The URL syntax is a path to the containing model repository, followed by a model identifier (the model's name) and the XMI-id of the model element. To qualify the relation of two elements linked by a trace, different types of references can be assigned to a) *traces between abstractions*, such as "realizes / is realized by", "refines / is refined by", "specifies / is specified by", "requires / is required by", etc. and b) *traces within abstractions*, such as "includes / is part of", "verifies / is verified by", "defines / is defined by", "constrains / is constrained by", etc. (see [12] or [5]).

```

<uml:Model>
  ...
  <packagedElement xmi:type="uml:Class" xmi:id="_CyIsaF-fEdySHqLLXw_Tew"
    name="Opportunity">
    <eAnnotations source="http://www.iese.fraunhofer.de/ModelMetaInformation">
      <details key="TraceabilityInformation" value="
        <!-- BEGIN: Embedded Traceability Information XML-string -->
        <TraceabilityInformation>
          <Trace
            urlToElement="http://iese.fhg.de/SalesOpportunity_CIM.bpmn#_TG7coT3iEd2hQ-HeytPXvA"
            type="realizes"
            rationale="Implementation of Opportunity data object"
            traceCreation="automatic" transitionAutomation="automatic"/>
          </TraceabilityInformation>
        <!-- END: Embedded Traceability Information XML-string -->
        "/>
      </eAnnotations>
    </packagedElement>
  </uml:Model>

```

Figure 3 Serialization of Traceability Information Annotation in PIM

As generative model-driven development relies on model transformations between abstraction levels, the information about whether a *trace creation* or *transition* between two related elements has been carried out manually, semi-automatically, or automatically is of interest, e.g. for evaluating the quality of model transformations/model generators or for determining the overall level of automation. The XML serialization of traceability information between an Opportunity data object at the CIM level and its implementation class at the PIM level is exemplified in Figure 3 (PIM-to-CIM) and Figure 4 (CIM-to-PIM).

```

<bpmn:BpmnDiagram>
...
<artifacts xmi:type="bpmn:DataObject" xmi:id="_TG7coT3iEd2hQ-HeytPXvA"
name="Opportunity">
<eAnnotations source="http://www.iese.fraunhofer.de/ModelMetaInformation">
<details key="TraceabilityInformation" value="
<!-- BEGIN: Embedded Traceability Information XML-string -->
<TraceabilityInformation>
<Trace
urlToElement="http://iese.fhg.de/SalesOpportunity_PIM.uml#_CyIsaF-fEdySHq1LXw_Tew"
type="isRealizedBy"
rationale="Implementation of Opportunity data object"
traceCreation="automatic" transitionAutomation="automatic"/>
</TraceabilityInformation>
<!-- END: Embedded Traceability Information XML-string -->
"/>
</eAnnotations>
</artifacts>
...
</bpmn:BpmnDiagram>

```

Figure 4 Serialization of Traceability Information Annotation in CIM

3 Visualizing (Defect) Annotations in Modeling Environments

The information stored within the annotations can be used, for example, by the diagram visualizer to enrich the standard UML diagrams with information about the defects. As presented in Figure 5, the VIDE Defect Detector (VIDE-DD) extends the Topcased modeling environment [10] and decodes the information within the annotation in order to decorate an element (e.g., a class) with a defect icon or list all annotations for the user (see ⑥). This tool is aimed at enriching the visualization of the models in order to inform designers and maintainers about potential threats to model quality.

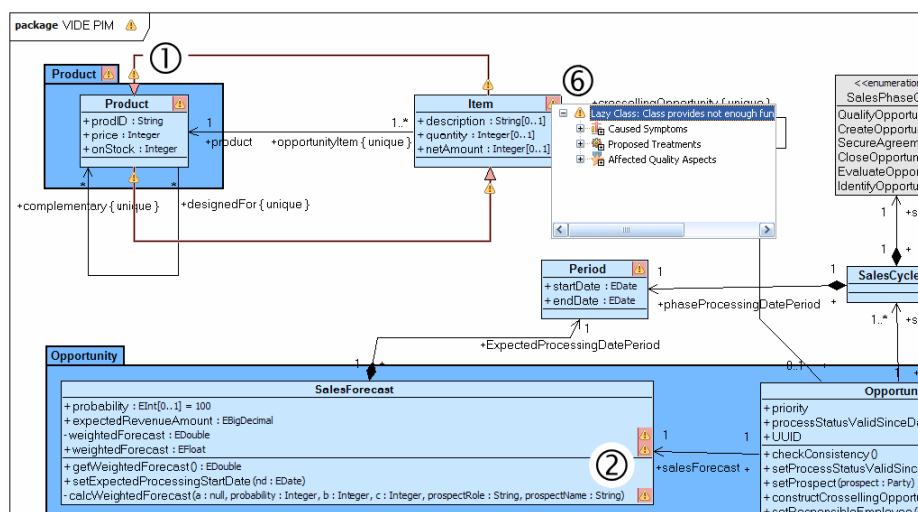


Figure 5 The VIDE Quality Defect Detector

4 Conclusion

We presented how additional information about defects, context, or traceability can be embedded in a UML- or BPMN-based software model (PIM or CIM) using Annotations. To structure the information within these annotations, we used an XML-based

metamodel that supports single- and multi-location annotations from CIM-to-PIM, within PIM, and from PIM-to-CIM. Furthermore, we presented a tool that integrates quality defect diagnosis into the contemporary modeling environment Topcased and uses the annotations to present them in standard diagrams.

In the future, more tools for defect diagnosis and traceability support will be developed and integrated into software development tools that have to overcome the challenges of synchronization and versioning. This is especially important for tools on the model level, as these have to support quality assurance in and traceability between multiple software and transformation models.

References

1. BPDM-Beta1, Business Process Definition MetaModel (BPDM), Beta 1, OMG Adopted Specification, OMG, dtc/07-07-01, 2007.
2. BPMN-1.1, Business Process Modeling Notation, V1.1, OMG, 2008.
3. DI-1.0, UML Diagram Interchange Specification, version 1.0, Specification, Object Management Group, Inc. (OMG), Needham, MA, USA, 2006.
4. EMF, "Eclipse Modeling Framework (EMF)," <http://www.eclipse.org/modeling/emf/>, last accessed on 1. April 2008.
5. A. Espinoza, P. P. Alarcon, and J. Garbajosa, Analyzing and Systematizing Current Traceability Schemas, In Annual IEEE/NASA Software Engineering Workshop (SEW), pp. 21-32, 2006.
6. Y. Feng, G. Huang, J. Yang, and H. M. Mei, Traceability between Software Architecture Models, In 30th Annual International Computer Software and Applications Conference (COMPSAC), pp. 41-44, 2006.
7. D. S. Kolovos, R. F. Paige, and F. A. C. Polack, On-Demand Merging of Traceability Links with Models, In 2nd EC-MDA Workshop on Traceability, 2006.
8. MOF-2.0, Meta Object Facility (MOF) Core Specification, version 2.0, Specification, Object Management Group, Inc. (OMG), Needham, MA, USA, formal/06-01-01, 2006.
9. J. Rech and A. Priestestersbach, Quality Defects in Model-driven Software Development, Deliverable, Fraunhofer Institute for Experimental Software Engineering (IESE), Kaiserslautern, D4.1, 2007.
10. TopCased, "Topcased IDE," <http://www.topcased.org/>, last accessed on 27 November 2007.
11. UML-2.1.1, Unified Modeling Language (UML), version 2.1.1, Object Management Group, Inc. (OMG), Needham, MA, USA, 2007.
12. A. von Knethen, Change-Oriented Requirements Traceability. Support for Evolution of Embedded Systems PhD Thesis. Kaiserslautern: University of Kaiserslautern, Department of Computer Science, 2002.